



NEW ENGLAND SEMICONDUCTOR

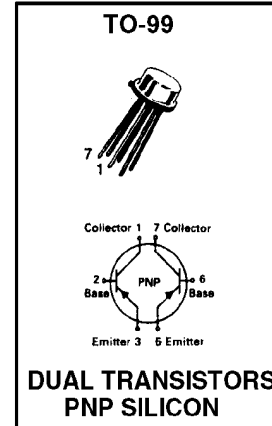
**2N3806,A
thru
2N3809,A
2N3810*,A
2N3811*,A**

*also available as
JAN, JANTX,
JANTXV

PNP SILICON DUAL AMPLIFIER TRANSISTOR

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

RATINGS	SYMBOL	VALUE	UNITS
Collector-Emitter Voltage	V_{CEO}	60	Vdc
Collector-Base Voltage	V_{CBO}	60	Vdc
Emitter-Base Voltage	V_{EBO}	5.0	Vdc
Collector Current -- Continuous	I_C	50	mAdc
		One Die	Both Die
Total Power Dissipation Derate above 25°C	P_D	500 2.86	mW mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristics	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage ⁽¹⁾ $I_C = 10 \text{ mAdc}, I_B = 0$	$V_{(BR)CEO}$	60		Vdc
Collector-Base Breakdown Voltage $I_C = 10 \mu\text{Adc}, I_E = 0$	$V_{(BR)CBO}$	60		Vdc
Emitter-Base Breakdown Voltage $I_E = 10 \mu\text{Adc}, I_C = 0$	$V_{(BR)EBO}$	5.0		Vdc
Collector Cutoff Current $V_{CB} = 50 \text{ Vdc}, I_E = 0$ $V_{CB} = 50 \text{ Vdc}, I_E = 0, T_A = 150^\circ\text{C}$	I_{CBO}		0.01 10	μAdc
Emitter Cutoff Current $V_{BE} = 4.0 \text{ Vdc}, I_C = 0$	I_{EBO}		20	ηAdc

ON CHARACTERISTICS (1)

DC Current Gain $I_C = 1.0 \mu\text{Adc}, V_{CE} = 5.0 \text{ Vdc}$ $I_C = 10 \mu\text{Adc}, V_{CE} = 5.0 \text{ Vdc}$ $I_C = 100 \mu\text{Adc}, V_{CE} = 5.0 \text{ Vdc}$ $I_C = 100 \mu\text{Adc}, V_{CE} = 5.0 \text{ Vdc}, T_A = -55^\circ\text{C}$ $I_C = 500 \mu\text{Adc}, V_{CE} = 5.0 \text{ Vdc}$ $I_C = 1.0 \text{ mAdc}, V_{CE} = 5.0 \text{ Vdc}$ $I_C = 10 \text{ mAdc}, V_{CE} = 5.0 \text{ Vdc}$	2N3807,9,11,A 2N3806,8,10,A 2N3807,9,11,A 2N3806,8,10,A 2N3807,9,11,A 2N3806,8,10,A 2N3807,9,11,A 2N3806,8,10,A 2N3807,9,11,A 2N3806,8,10,A 2N3807,9,11,A 2N3806,8,10,A	h_{FE}	75 100 225 150 300 75 150 150 300 150 300 125 250	450 900	--
Collector-Emitter Saturation Voltage $I_C = 100 \mu\text{Adc}, I_B = 1.0 \mu\text{Adc}$ $I_C = 1.0 \text{ mAdc}, I_B = 100 \mu\text{Adc}$		$V_{CE(sat)}$		0.2 0.25	Vdc
Base-Emitter Saturation Voltage $I_C = 100 \mu\text{Adc}, I_B = 10 \mu\text{Adc}$ $I_C = 1.0 \text{ mAdc}, I_B = 100 \mu\text{Adc}$		$V_{BE(sat)}$		0.7 0.8	Vdc

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6 Lake Street Lawrence, MA 01841
1-800-446-1158 / (978) 794-1666 / FAX: (978) 689-0803

T4-4.8-860-356 REV: --



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ELECTRICAL CHARACTERISTICS..con't.. ($T_A = 25^{\circ}\text{C}$ unless otherwise noted)

Characteristics	Symbol	Min	Max	Unit
ON CHARACTERISTICS (1) con't				
Base-Emitter On Voltage $I_C = 100 \mu\text{A}$, $V_{CE} = 10 \mu\text{A}$	$V_{BE(on)}$		0.7	Vdc
SMALL-SIGNAL CHARACTERISTICS				
Current-Gain -- Bandwidth Product $I_C = 500 \mu\text{A}$, $V_{CE} = 5.0 \text{ Vdc}$, $f = 30 \text{ Mhz}$ $I_C = 1.0 \text{ mA}$, $V_{CE} = 5.0 \text{ Vdc}$, $f = 100 \text{ Mhz}$	f_T	30 100	- 500	MHz
Output Capacitance $V_{CB} = 5.0 \text{ Vdc}$, $I_E = 0$, $f = 100 \text{ kHz}$	C_{obo}		4.0	p^f
Input Capacitance $V_{BE} = 0.5 \text{ Vdc}$, $I_C = 0$, $f = 100 \text{ kHz}$	C_{ibo}		8.0	p^f
Input Impedance $I_C = 1.0 \text{ mA}$, $V_{CE} = 10 \text{ Vdc}$, $f = 1.0 \text{ kHz}$	h_{je}	3.0 10	30 40	$\text{k}\Omega$
Voltage Feedback Ratio $I_C = 1.0 \text{ mA}$, $V_{CE} = 10 \text{ Vdc}$, $f = 1.0 \text{ kHz}$	h_{re}		25	$\times 10^{-4}$
Small-Signal Current Gain $I_C = 1.0 \text{ mA}$, $V_{CE} = 10 \text{ Vdc}$, $f = 1.0 \text{ kHz}$	h_{fe}	150 300	600 900	--
Output Admittance $I_C = 1.0 \text{ mA}$, $V_{CE} = 10 \text{ Vdc}$, $f = 1.0 \text{ kHz}$	h_{oe}	5.0	60	μmhos
Noise Figure $I_C = 100 \mu\text{A}$, $V_{CE} = 10 \text{ Vdc}$, $R_G = 3.0 \text{ kohms}$ $f = 100 \text{ Hz}$, $\text{BW} = 20 \text{ Hz}$	NF		7.0 4.0	dB
Spot Noise $f = 1.0 \text{ kHz}$, $\text{BW} = 200 \text{ Hz}$			3.0	
$f = 10 \text{ kHz}$, $\text{BW} = 2.0 \text{ kHz}$			1.5	
Broadband Noise Bandwidth 10 Hz to 15.7 kHz			2.5	
MATCHING CHARACTERISTICS				
DC Current Gain Ratio (2) $I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ Vdc}$	h_{FE1}/h_{FE2}	0.8 0.9 0.95 0.85	1.0 1.0 1.0 1.0	--
$T_A = -55$ to $+125^{\circ}\text{C}$				
Base-Emitter Voltage Differential $I_C = 10 \mu\text{A}$ to 10 mA , $V_{CE} = 5.0 \text{ Vdc}$	$V_{BE1} - V_{BE2}$		8.0 5.0 5.0 3.0 1.5	mVdc
$I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ Vdc}$				
Base-Emitter Voltage Differential Change Due to Temperature $I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ Vdc}$ $T_A = -55$ to $+125^{\circ}\text{C}$	$\Delta V_{BE1} - V_{BE2}$		1.6 0.8 0.4 2.0 1.0 0.5	mVdc
$I_C = 100 \mu\text{A}$, $V_{CE} = 5.0 \text{ Vdc}$ $T_A = +25$ to $+125^{\circ}\text{C}$				

(1) Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

(2) The lowest h_{FE} reading is taken as h_{FE1} for this ratio.

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